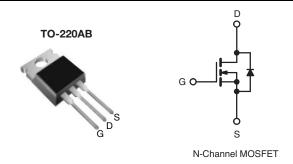


Vishay Siliconix

Power MOSFET

PRODUCT SUMMARY				
V _{DS} (V)	500			
R _{DS(on)} (Ω)	V _{GS} = 10 V	0.85		
Q _g (Max.) (nC)	39			
Q _{gs} (nC)	10			
Q _{gd} (nC)	19			
Configuration	Single			



FEATURES

- Ultra Low Gate Charge
- Reduced Gate Drive Requirement
- Enhanced 30 V V_{GS} Rating
- Reduced C_{iss}, C_{oss}, C_{rss}
- Extremely High Frequency Operation
- Repetitive Avalanche Rated
- Compliant to RoHS Directive 2002/95/EC

DESCRIPTION

This new series of low charge Power MOSFETs achieve signiticantly lower gate charge over conventional MOSFETs. Utilizing the new LCDMOS technology, the device improvements are achieved without added product cost, allowing for reduced gate drive requirements and total system savings. In addition, reduced switching losses and improved efficiency are achievable in a variety of high frequency applications. Frequencies of a few MHz at high current are possible using the new low charge MOSFETs.

These device improvements combined with the proven ruggedness and reliability that are characteristic of Power MOSFETs offer the designer a new standard in power transistors for switching applications.

ORDERING INFORMATION		
Package	TO-220AB	
Lead (Pb)-free	IRF840LCPbF	
Lead (Fb)-life	SiHF840LC-E3	
SnPb	IRF840LC	
	SiHF840LC	

ABSOLUTE MAXIMUM RATINGS (T_C	= 20 0, armood other wid			1	
PARAMETER	SYMBOL	LIMIT	UNIT		
Drain-Source Voltage		V_{DS}	500	V	
Gate-Source Voltage	V_{GS}	± 30	7 v		
Continuous Drain Current	V_{GS} at 10 V $T_C = 25 ^{\circ}\text{C}$	I-	8.0	А	
	V_{GS} at 10 V $T_C = 100 ^{\circ}C$	I _D	5.1		
Pulsed Drain Current ^a	I _{DM}	28			
Linear Derating Factor			1.0	W/°C	
Single Pulse Avalanche Energy ^b	E _{AS}	510	mJ		
Repetitive Avalanche Current ^a	I _{AR}	8.0	А		
Repetitive Avalanche Energy ^a	E _{AR}	13	mJ		
Maximum Power Dissipation	T _C = 25 °C		125	W	
Peak Diode Recovery dV/dtc	dV/dt	3.5	V/ns		
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to + 150	°C	
Soldering Recommendations (Peak Temperature)	for 10 s	_	300 ^d	7	
Mounting Torque	6 20 or M2 corour		10	lbf ⋅ in	
	6-32 or M3 screw		1.1	N⋅m	

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. $V_{DD} = 50 \text{ V}$, starting $T_J = 25 \,^{\circ}\text{C}$, $L = 14 \,^{\circ}\text{mH}$, $R_g = 25 \,^{\circ}\Omega$, $I_{AS} = 8.0 \,^{\circ}\text{A}$ (see fig. 12).
- c. $I_{SD} \le 8.0 \text{ A}$, $dI/dt \le 100 \text{ A/}\mu\text{s}$, $V_{DD} \le V_{DS}$, $T_{J} \le 150 \text{ °C}$.
- d. 1.6 mm from case.

^{*} Pb containing terminations are not RoHS compliant, exemptions may apply

IRF840LC, SiHF840LC

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THERMAL RESISTANCE				
PARAMETER	SYMBOL	TYP.	MAX.	UNIT
Maximum Junction-to-Ambient	R _{thJA}	-	62	
Case-to-Sink, Flat, Greased Surface	R _{thCS}	0.50	-	°C/W
Maximum Junction-to-Case (Drain)	R _{thJC}	-	1.0	

PARAMETER	SYMBOL	TES	T CONDITIONS	MIN.	TYP.	MAX.	UNIT
Static							
Drain-Source Breakdown Voltage	V _{DS}	V _{GS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	e to 25 °C, I _D = 1 mA	-	0.63	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} :	= V _{GS} , I _D = 250 μA	2.0	-	4.0	V
Gate-Source Leakage	I _{GSS}	V _{GS} = ± 20 V		-	-	± 100	nA
Zero Gate Voltage Drain Current	I _{DSS}		$V_{DS} = 500 \text{ V}, V_{GS} = 0 \text{ V}$ $V_{DS} = 400 \text{V}, V_{GS} = 0 \text{ V}, T_J = 125 ^{\circ}\text{C}$		-	25 250	μA
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 4.8 A ^b	-	_	0.85	Ω
Forward Transconductance	9 _{fs}	V _{DS} :	= 50 V, I _D = 4.8 A ^b	4.0	-	-	S
Dynamic							
Input Capacitance	C _{iss}	$V_{GS} = 0 \text{ V},$ $V_{DS} = 25 \text{ V},$ $f = 1.0 \text{ MHz}, \text{ see fig. } 5$		-	1100	-	
Output Capacitance	C _{oss}			-	170	-	рF
Reverse Transfer Capacitance	C _{rss}			-	18	-	
Total Gate Charge	Qg	$V_{GS} = 10 \text{ V}$ $I_D = 8.0 \text{ A}, V_{DS} = 400 \text{ V}$ see fig. 6 and 13 ^b		-	-	39	
Gate-Source Charge	Q _{gs}		-	-	10	nC	
Gate-Drain Charge	Q_{gd}		-	-	19		
Turn-On Delay Time	t _{d(on)}	V_{DD} = 250 V, I_{D} = 8.0 A, R_{g} = 9.1 Ω, R_{D} = 30 Ω see fig. 10 ^b		ı	12	-	- ns
Rise Time	t _r			ı	25	-	
Turn-Off Delay Time	$t_{d(off)}$			-	27	-	
Fall Time	t _f			-	19	-	
Internal Drain Inductance	L_D	6 mm (0.25")	Between lead, 6 mm (0.25") from		4.5	-	ъЦ
Internal Source Inductance	L _S	package and center of die contact		-	7.5	-	- nH
Drain-Source Body Diode Characteristic	s						
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the integral reverse p - n junction diode		-	-	8.0	^
Pulsed Diode Forward Current ^a	I _{SM}			-	-	28	A
Body Diode Voltage	V _{SD}	$T_J = 25 ^{\circ}\text{C}, I_S = 8.0 \text{A}, V_{GS} = 0 \text{V}^{\text{b}}$		-	-	2.0	V
Body Diode Reverse Recovery Time	t _{rr}	T _J = 25 °C, I _F = 8.0 A, dl/dt = 100 A/μs ^b		-	490	740	ns
Body Diode Reverse Recovery Charge	Q _{rr}			-	3.0	4.5	μC
Forward Turn-On Time	t _{on}	Intrinsic turn-on time is negligible (turn-on is dominated by L _S and L				Ln)	

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width \leq 300 μ s; duty cycle \leq 2 %.



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

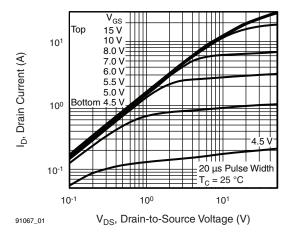


Fig. 1 - Typical Output Characteristics, T_C = 25 °C

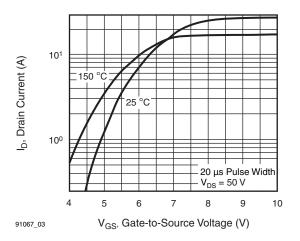


Fig. 3 - Typical Transfer Characteristics

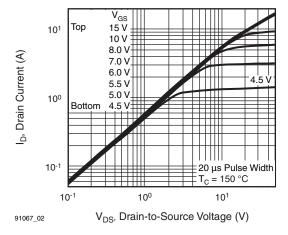


Fig. 2 - Typical Output Characteristics, T_C = 150 °C

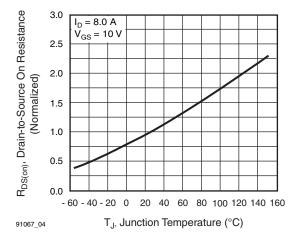
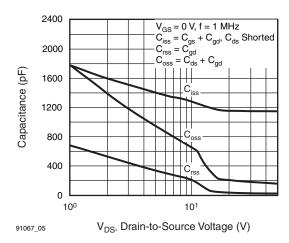


Fig. 4 - Normalized On-Resistance vs. Temperature

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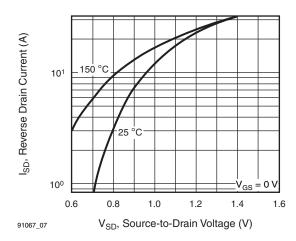
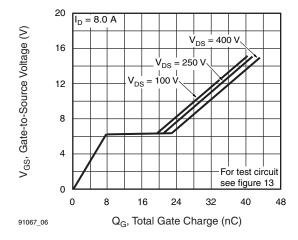


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

Fig. 7 - Typical Source-Drain Diode Forward Voltage



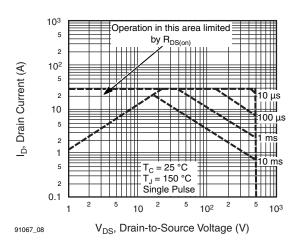


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

Fig. 8 - Maximum Safe Operating Area



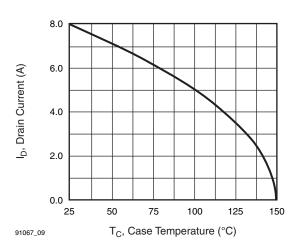


Fig. 9 - Maximum Drain Current vs. Case Temperature

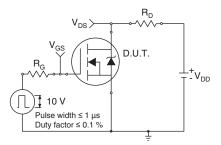


Fig. 10a - Switching Time Test Circuit

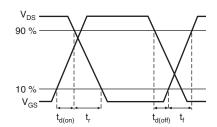


Fig. 10b - Switching Time Waveforms

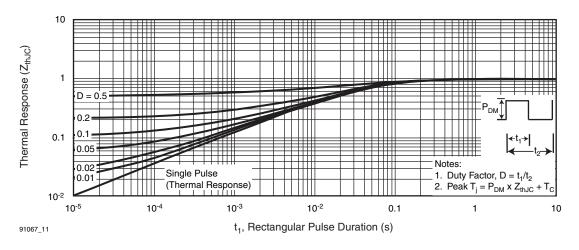


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

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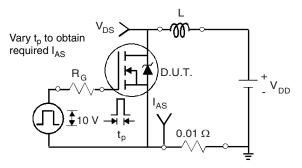


Fig. 12a - Unclamped Inductive Test Circuit

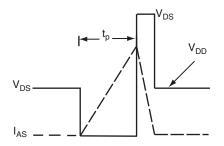


Fig. 12b - Unclamped Inductive Waveforms

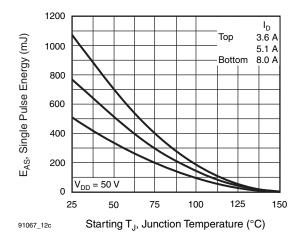


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

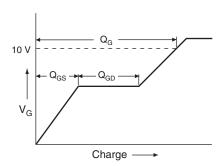


Fig. 13a - Basic Gate Charge Waveform

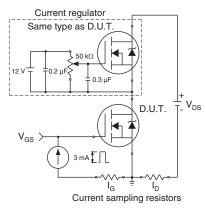
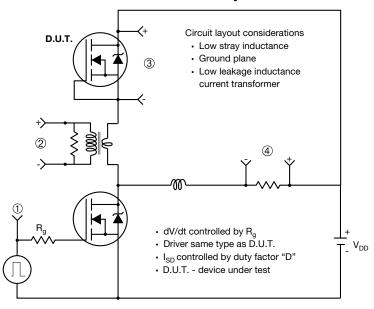


Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit



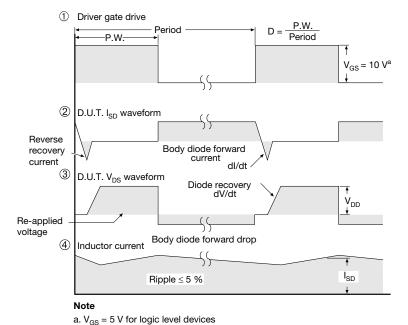


Fig. 14 - For N-Channel

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